

U. S. DEPARTMENT OF COMMERCE
Sheet 1 of 1

PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT

Atty Docket No.: 5031-2
Serial No.: n/a
Applicant: Sergio PICCIOLI

Filing Date: Concurrently Herewith
Group Art:

JC971 U.S. PTO
09/882143
06/14/01

U.S. PATENT DOCUMENTS

*Ex. Intls.		Document No.	Date	Name	Class	Subclass	Filing Date
HTD	AA	3,942,169	3/2/1976	Y. Fujimoto et al.	340	146.3	9/6/1974
	AR	5,974,403	10/26/1999	S. Takriti et al.	705	412	7/21/1997
	AC	5,761,442	6/2/1998	D. S. Barr et al.	395	236	8/31/1994
	AD	5,444,819	8/22/1995	M. Negishi	395	22	4/27/1993
	AE	5,761,386	6/2/1998	S. R. Lawrence	395	23	6/16/1997
	AF	5,544,281	8/6/1996	T. Maruoka et al.	395	68	3/23/1994
	AG	5,956,702	9/21/1999	M. Matsuoka et al.	706	22	8/22/1996
	AH	5,109,475	4/28/1992	M. Kosaka et al.	395	22	8/14/1989
	AI	6,122,399	9/19/2000	M. C. Moed	382	159	9/4/1997
	AJ	5,422,981	6/6/1995	T. Niki	395	22	11/18/1991
	AK	5,967,981	10/19/1999	R. L. Watrous	600	428	9/26/1997
	AL	5,796,611	8/18/1998	K. Ochiai et al.	364	420	10/3/1995
	AM	5,461,699	10/24/1995	M. Arbabi et al.	395	23	10/25/1993
	AN	5,414,838	5/9/1995	A. D. Kolton et al.	395	600	6/11/1992
	AO	6,119,103	9/12/2000	C. A. Basch et al.	705	35	5/27/1997
	AP	5,832,456	11/3/1998	F.D. Fox et al.	705	10	1/18/1996
	AQ	6,035,295	3/7/2000	L. C. Klein	707	6	11/24/1998
	AR	5,664,174	9/2/1997	R. Agrawal et al.	395	606	5/9/1995
↓	AS	5,778,357	7/7/1998	A.D. Kolton et al.	707	2	12/30/1996
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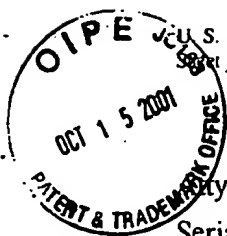
FOREIGN PATENT DOCUMENTS

*Ex. Intls.		Document No.	Date	Country	Name	Class	Subclass	Translation Yes/No
	AU							
	AV							

EXAMINER: Han 170a

DATE CONSIDERED: 6/16/06

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U.S. DEPARTMENT OF COMMERCE

PATENT AND TRADEMARK OFFICE

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Filing Date: June 14, 2001
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*Ex. Intls.		Document No.	Date	Name	Class	Subclass	Filing Date
H7D	AA	6,236,980	May 22, 2001	Reese	705	36	April 9, 1998
	AB	6,088,676	July 11, 2000	H. White, Jr.	705	1	March 26, 1999
	AC	6,078,904	June 20, 2000	G. Rebane	705	36	March 16, 1998
	AD	5,313,560	May 17, 1994	T. Maruoka et al.	395	54	May 8, 1991
	AE	5,918,217	June 29, 1999	J. Maggioncalda et al.	705	36	December 10, 1997
✓	AF	5,893,069	April 6, 1999	H. White, Jr.	705	1	January 31, 1997

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	AH							
	AI							
	AJ							
	AK							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AL		
	AM		
	AN		

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